

Electrical Characteristics @ T_j = 25°C (Unless Otherwise Specified)

| Symbol | Parameter | Min. | Typ. | Max. | Units | Test Conditions |
|-------------------------------------|--------------------------------------|------|------|------|-------|---|
| BV _{DSS} | Drain-to-Source Breakdown Voltage | 500 | — | — | V | V _{GS} = 0V, I _D = 1.0mA |
| ΔBV _{DSS} /ΔT _J | Breakdown Voltage Temp. Coefficient | — | 0.78 | — | V/°C | Reference to 25°C, I _D = 1.0mA |
| R _{DS(on)} | Static Drain-to-Source On-Resistance | — | — | 0.27 | Ω | V _{GS} = 10V, I _{D2} = 14A ④ |
| | | — | — | 0.31 | | V _{GS} = 10V, I _{D2} = 21A ④ |
| V _{GS(th)} | Gate Threshold Voltage | 2.0 | — | 4.0 | V | V _{DS} = V _{GS} , I _D = 250μA |
| I _{DSS} | Zero Gate Voltage Drain Current | — | — | 25 | μA | V _{DS} = 400V, V _{GS} = 0V |
| | | — | — | 250 | | V _{DS} = 400V, V _{GS} = 0V, T _J = 125°C |
| I _{GSS} | Gate-to-Source Leakage Forward | — | — | 100 | nA | V _{GS} = 20V |
| | Gate-to-Source Leakage Reverse | — | — | -100 | | V _{GS} = -20V |
| Q _G | Total Gate Charge | 84 | — | 190 | nC | I _{D1} = 21A |
| Q _{GS} | Gate-to-Source Charge | 12 | — | 27 | | V _{DS} = 250V |
| Q _{GD} | Gate-to-Drain ('Miller') Charge | 60 | — | 135 | | V _{GS} = 10V |
| t _{d(on)} | Turn-On Delay Time | — | — | 35 | ns | V _{DD} = 250V |
| t _r | Rise Time | — | — | 120 | | I _{D1} = 21A |
| t _{d(off)} | Turn-Off Delay Time | — | — | 130 | | R _G = 2.35Ω |
| t _f | Fall Time | — | — | 98 | | V _{GS} = 10V |
| L _S + L _D | Total Inductance | — | 6.1 | — | nH | Measured from Drain lead (6mm / 0.25 in from package) to Source lead (6mm / 0.25 in from package) |
| C _{iSS} | Input Capacitance | — | 4300 | — | pF | V _{GS} = 0V |
| C _{oss} | Output Capacitance | — | 1000 | — | | V _{DS} = 25V |
| C _{rSS} | Reverse Transfer Capacitance | — | 250 | — | | f = 1.0MHz |

Source-Drain Diode Ratings and Characteristics

| Symbol | Parameter | Min. | Typ. | Max. | Units | Test Conditions |
|-----------------|--|--|------|------|-------|--|
| I _S | Continuous Source Current (Body Diode) | — | — | 21 | A | T _J = 25°C, I _S = 21A, V _{GS} = 0V④ |
| I _{SM} | Pulsed Source Current (Body Diode) ① | — | — | 84 | | |
| V _{SD} | Diode Forward Voltage | — | — | 1.8 | V | T _J = 25°C, I _S = 21A, V _{GS} = 0V④ |
| t _{rr} | Reverse Recovery Time | — | — | 580 | ns | T _J = 25°C, I _F = 21A, V _{DD} ≤ 50V |
| Q _{rr} | Reverse Recovery Charge | — | — | 8.1 | μC | di/dt = 100A/μs ④ |
| t _{on} | Forward Turn-On Time | Intrinsic turn-on time is negligible (turn-on is dominated by L _S +L _D) | | | | |

Thermal Resistance

| Symbol | Parameter | Min. | Typ. | Max. | Units |
|------------------|--|------|------|------|-------|
| R _{θJC} | Junction-to-Case | — | — | 0.42 | °C/W |
| R _{θJA} | Junction-to-Ambient (Typical socket mount) | — | — | 30 | |

Footnotes:

- ① Repetitive Rating; Pulse width limited by maximum junction temperature.
- ② V_{DD} = 50V, starting T_J = 25°C, L = 5.44mH, Peak I_L = 21A, V_{GS} = 10V.
- ③ I_{SD} ≤ 21A, di/dt ≤ 160A/μs, V_{DD} ≤ 500V, T_J ≤ 150°C. Suggested R_G = 2.35Ω
- ④ Pulse width ≤ 300 μs; Duty Cycle ≤ 2%

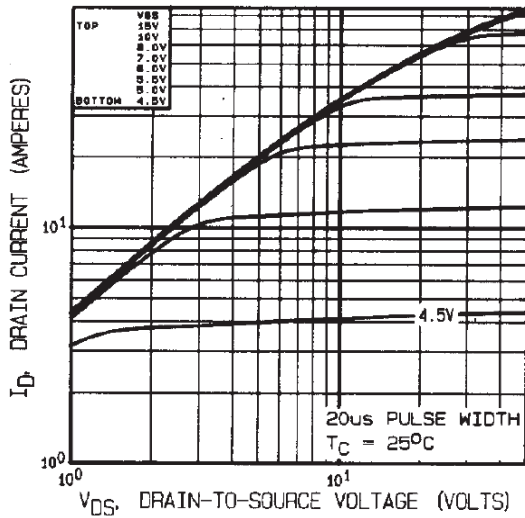


Fig 1. Typical Output Characteristics

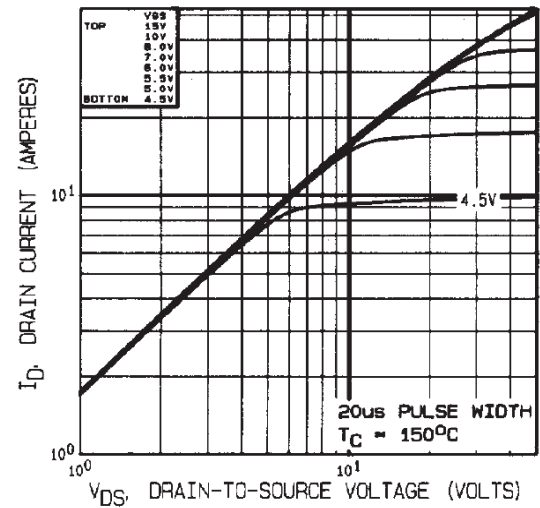


Fig 2. Typical Output Characteristics

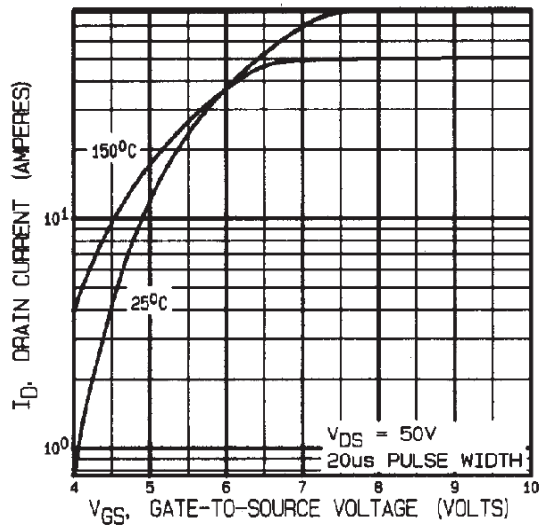


Fig 3. Typical Transfer Characteristics

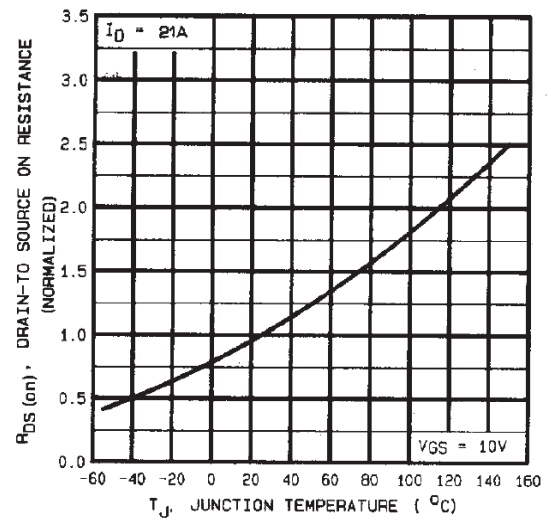


Fig 4. Normalized On-Resistance Vs. Temperature

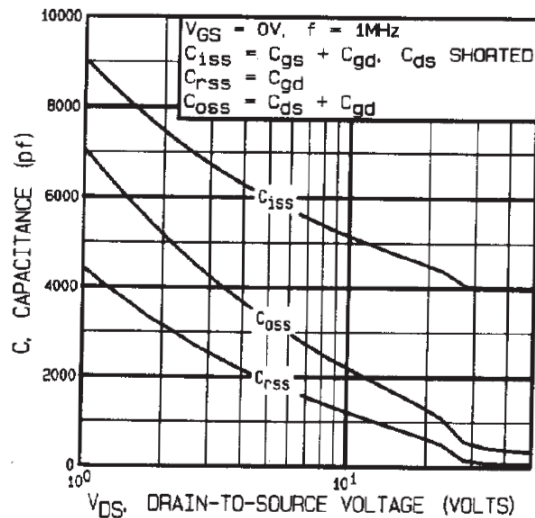


Fig 5. Typical Capacitance Vs. Drain-to-Source Voltage

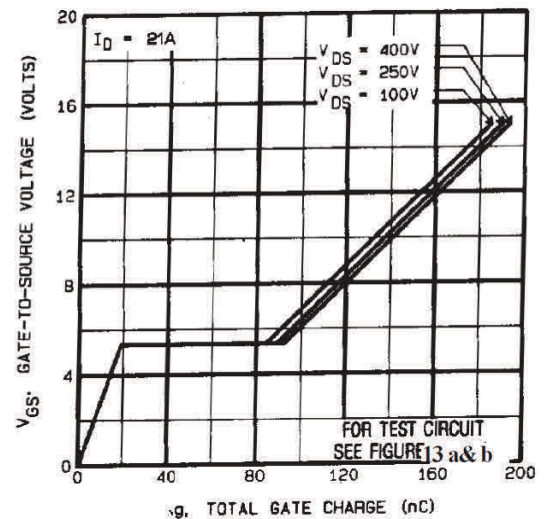


Fig 6. Typical Gate Charge Vs. Gate-to-Source Voltage

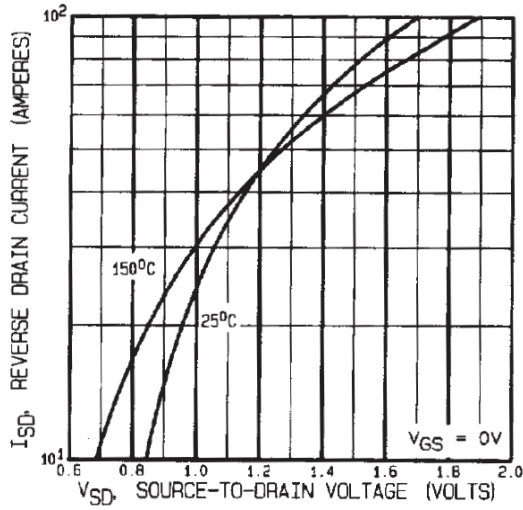


Fig 7. Typical Source-Drain Diode Forward Voltage

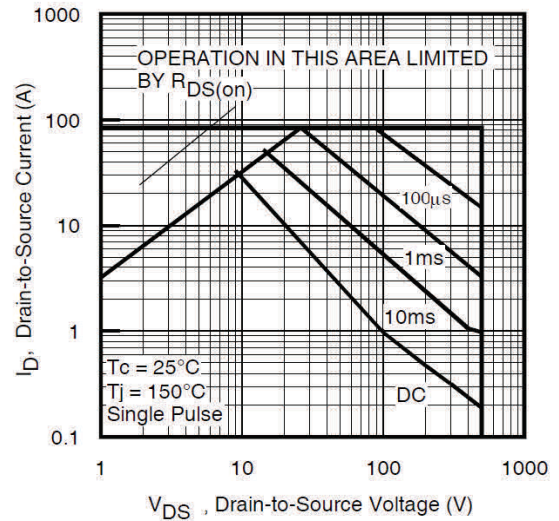


Fig 8. Maximum Safe Operating Area

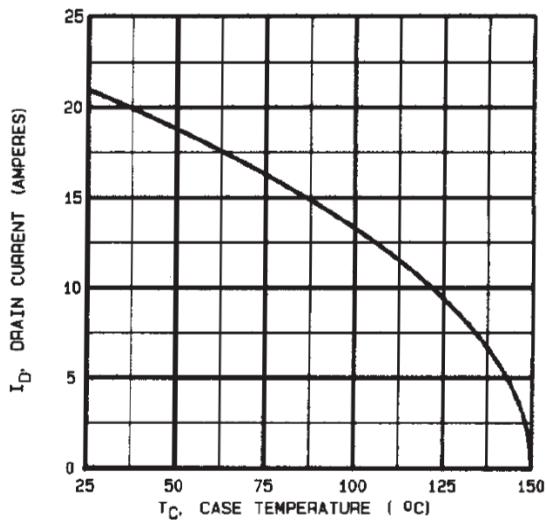


Fig 9. Maximum Drain Current Vs. Case Temperature

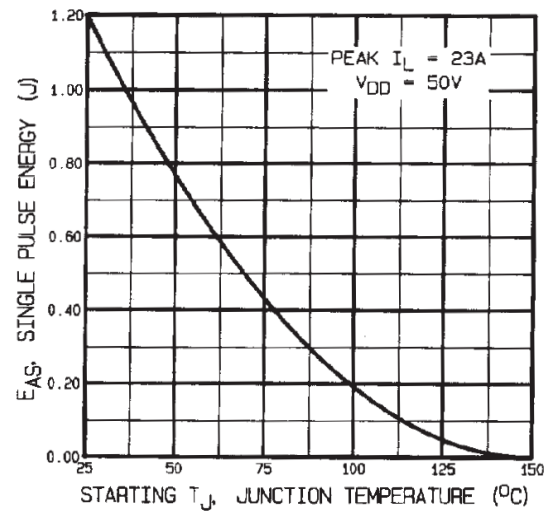


Fig 10. Maximum Avalanche Energy Vs. Drain Current

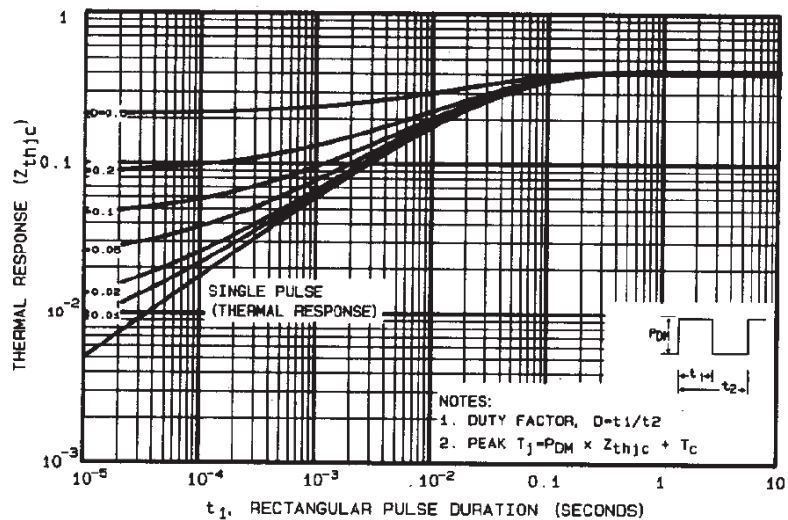


Fig 11. Maximum Effective Transient Thermal Impedance, Junction-to-Case

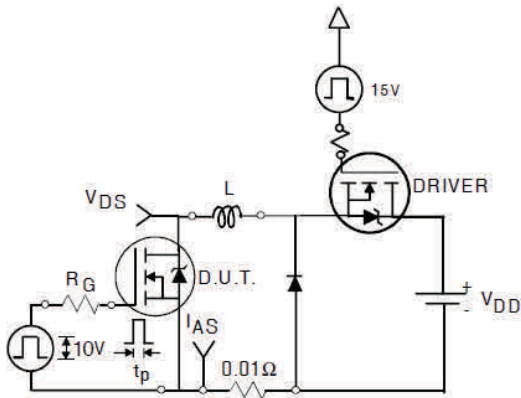


Fig 12a. Unclamped Inductive Test Circuit

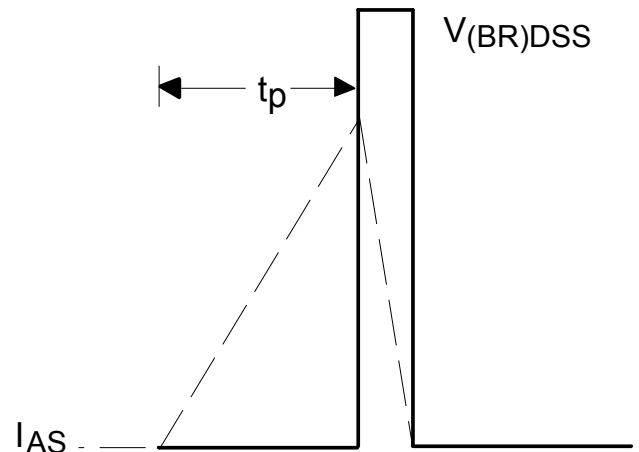


Fig 12b. Unclamped Inductive Waveforms

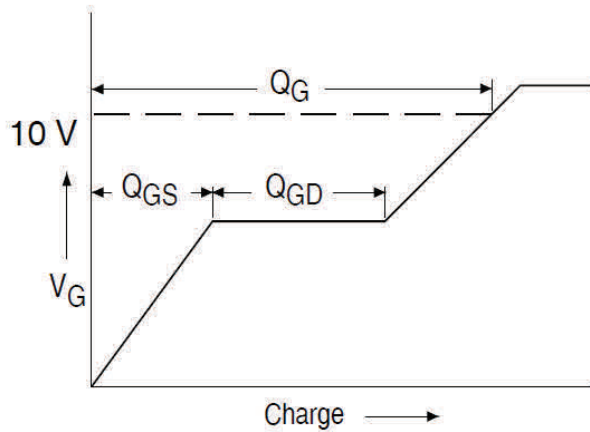


Fig 13a. Gate Charge Waveform

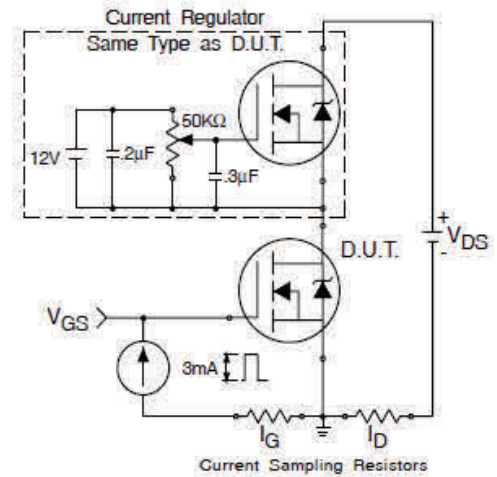


Fig 13b. Gate Charge Test Circuit

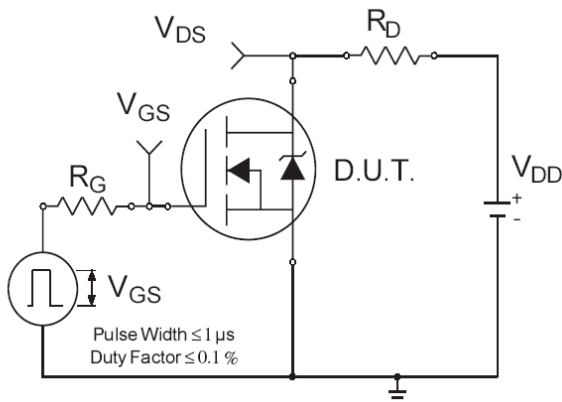


Fig 14a. Switching Time Test Circuit

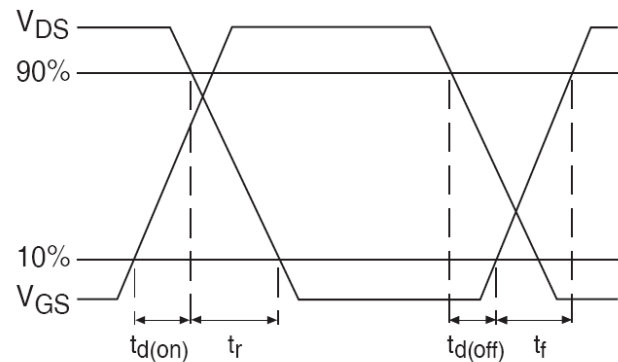


Fig 14b. Switching Time Waveforms

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